

A Complete Bibliography of Publications in *Technometrics* for the decade 1960–1969

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Title word cross-reference

2 [DT68]. 2^{17-9} [Add65, Pre66]. 2^{k-p} [BH61a, BH61b]. 2^n
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[Har66]. t [DT68, GB65, Hal63, Kra66b, Owe68]. T^2 [JB61]. U [Sho67b]. V
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3 [BCK78, Hay68, Luk64a].

4 [Luk64b].

5 [Ter65].

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Variance [And65, Boc63, BA63, CR66, Gla62, HH69, JL69, Koc67a, Koc68,
KA67, LNJE68, Man64a, NH69, Owe65b, SV69, TM63, Tuk61, ZT68, LN66,
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[Dun60, Har66, NG68]. **Vectors** [SS62]. **Version** [San68]. **versus** [RS65].
Vertices [Dia67, Gor66, MA66]. **Victor** [Coh66a]. **Viewpoint** [Gei66].
ViewpointPart [Gei66]. **VII** [Cox92]. **Vogl** [Hes68]. **Vol**
[Bar63c, Coo66, Hay68, Luk64a, Luk64b, McK69d, Par64, Pfa63a, Sam69].
Volume [All63, Ano60j, Ano611, Ano62l, Ano63n, Ano64m, Ano65p, Ano66o,
Ano67m, Ano68k, Ano69k, Gru67, Lea67, Olm62, Ter65, Zys64, Cox92].
Volumes [Ano66i, Ram66]. **vs** [LE64, Pet64, Tuk60].

W [Blo66, Buc67, Bur68, Cox92, Dan63, De 64, Dyk66a, Dyk67a, Fis67, Gei62, Gei63, Lau68, Man61, McL69, Neu68, Olm63, Roo63, Tho67, Zel62a]. **Waiting** [Hal64, Neu68]. **Waiting-Line** [Neu68]. **Wallace** [Ans65, Jac65]. **Walsh** [Dav66, Noe63]. **Walter** [Sch66]. **Wani** [Lev66]. **Warning** [Pag63]. **Wasow** [Ham62]. **Watson** [Gur65, Pat63a]. **Wave** [PG65]. **Wave-Analyser** [PG65]. **Way** [Ano65i, BG78, WW64]. **Wear** [SV68]. **Weibull** [Ano64g, Ano73, Eps64a, BA67, Coh65, Dub65, Dub67b, Dub67a, HM65a, HM65b, Jae64a, JL66, Joh66c, Kao64, Man67, Man68, Men63, Qur64, QNA65, SL63, TBA69, TB69, Whi69]. **Weight** [DL67, Rob69]. **Weighting** [Man64a]. **Weights** [Jae65]. **Weiler** [Ano67h]. **Weiss** [Chu66a]. **Weissberg** [Ano61g]. **Wetherill** [BLH⁺60, Cad69, Joh68]. **Where** [ZT68]. **Which** [DHT69, Wei62b]. **White** [Ano80]. **Whitney** [Sho67b]. **Wiener** [Rob63]. **Wilcoxon** [Dun66, Sho67b]. **Wild** [Kru60]. **Wilks** [Cap66]. **William** [Gru67, Low65, Sam69]. **Williams** [Gil66]. **Williamson** [Ste65]. **Window** [Won61]. **Wine** [Min65b]. **Winsorized** [DT68]. **Wisconsin** [Str69]. **Wolfe** [Ano78]. **Wolfgang** [Ham62]. **Work** [Owe69]. **Workbook** [Hic68]. **works** [Cox92]. **World** [Hog66]. **wrong** [Kus69].

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